

High Temperature Silicon Carbide Power Schottky Diode

V_{RRM}	=	1200 V
V_F	=	1.6 V
I_F	=	10 A
Q_C	=	95 nC

Features

- 1200 V Schottky rectifier
- 250 °C maximum operating temperature
- Electrically isolated base-plate
- Zero reverse recovery charge
- Superior surge current capability
- Positive temperature coefficient of V_F
- Temperature independent switching behavior
- Lowest figure of merit Q_C/I_F
- Available screened to Mil-PRF-19500

Package

- RoHS Compliant



TO – 257 (Isolated Base-plate Hermetic Package)

Advantages

- High temperature operation
- Improved circuit efficiency (Lower overall cost)
- Low switching losses
- Ease of paralleling devices without thermal runaway
- Smaller heat sink requirements
- Industry's lowest reverse recovery charge
- Industry's lowest device capacitance
- Ideal for output switching of power supplies
- Best in class reverse leakage current at operating temperature

Applications

- Down Hole Oil Drilling, Geothermal Instrumentation
- High Temperature DC/DC Converters
- High Temperature Motor and Servo Drives
- High Temperature Inverters
- High Temperature Actuator Control
- Military Power Supplies

Maximum Ratings at T_j = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Repetitive peak reverse voltage	V _{RRM}		1200	V
Continuous forward current	I _F	T _C ≤ 225 °C	9.4	A
RMS forward current	I _{F(RMS)}	T _C ≤ 225 °C	16	A
Surge non-repetitive forward current, Half Sine Wave	I _{F,SM}	T _C = 25 °C, t _p = 10 ms	65	A
Non-repetitive peak forward current	I _{F,max}	T _C = 25 °C, t _p = 10 μs	280	A
I ² t value	$\int I^2 dt$	T _C = 25 °C, t _p = 10 ms	20	A ² S
Power dissipation	P _{tot}	T _C = 25 °C	208	W
Operating and storage temperature	T _j , T _{stg}		-55 to 250	°C

Electrical Characteristics at T_j = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Diode forward voltage	V _F	I _F = 10 A, T _j = 25 °C	1.6	2.3		V
		I _F = 10 A, T _j = 210 °C	2.3			
Reverse current	I _R	V _R = 1200 V, T _j = 25 °C	1	55	300	μA
		V _R = 1200 V, T _j = 250 °C	55			
Total capacitive charge	Q _C	I _F ≤ I _{F,MAX} dI _F /dt = 200 A/μs T _j = 210 °C	V _R = 400 V	58		nC
			V _R = 960 V	95		
Switching time	t _s	V _R = 400 V V _R = 960 V	< 49			ns
			< 49			
Total capacitance	C	V _R = 1 V, f = 1 MHz, T _j = 25 °C	884			pF
		V _R = 400 V, f = 1 MHz, T _j = 25 °C	79			
		V _R = 1000 V, f = 1 MHz, T _j = 25 °C	63			

Thermal Characteristics

Thermal resistance, junction - case	R _{thJC}	1.08	°C/W
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Mechanical Properties

Mounting torque	M	0.6	Nm
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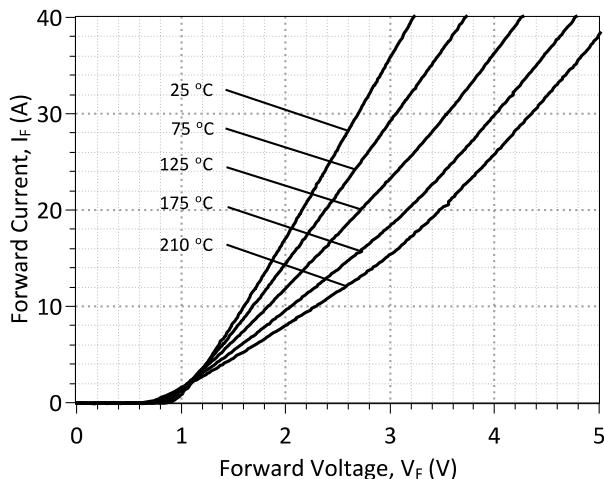


Figure 1: Typical Forward Characteristics

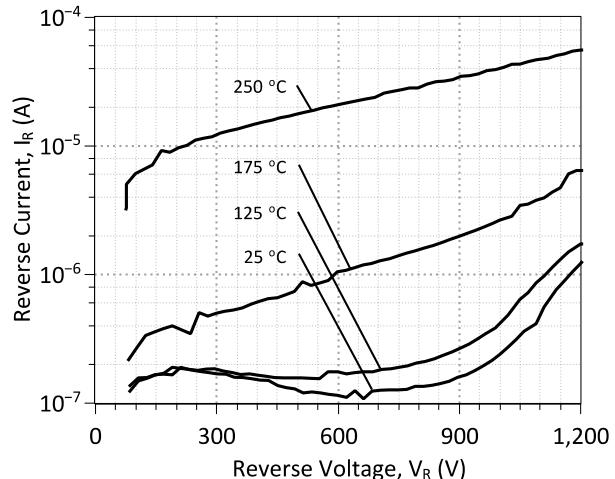


Figure 2: Typical Reverse Characteristics

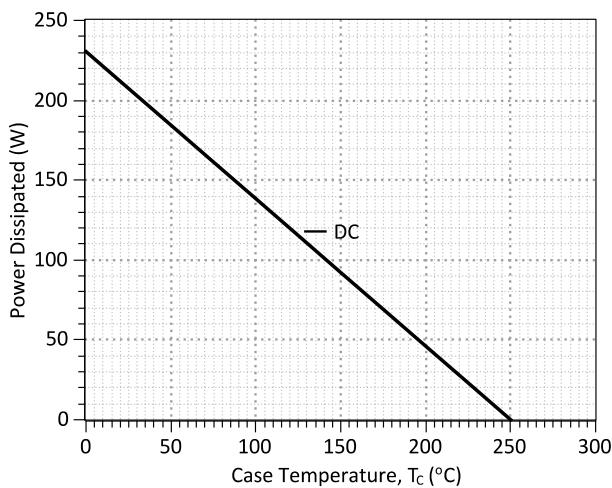


Figure 3: Power Derating Curve

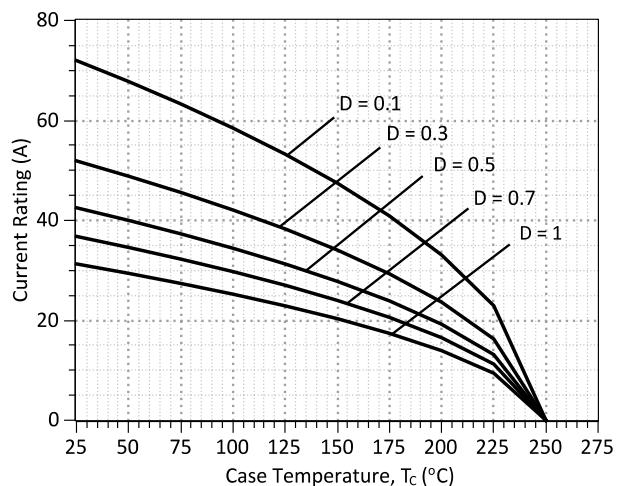


Figure 4: Current Derating Curves ($D = t_p/T$, $t_p = 400 \mu s$)
 (Considering worst case Z_{th} conditions)

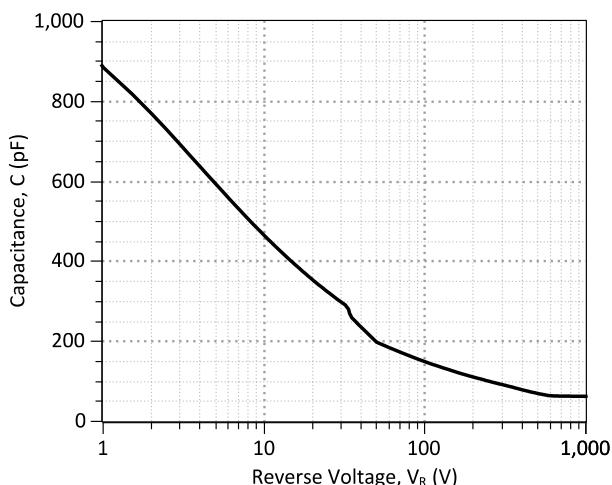


Figure 5: Typical Junction Capacitance vs Reverse Voltage Characteristics

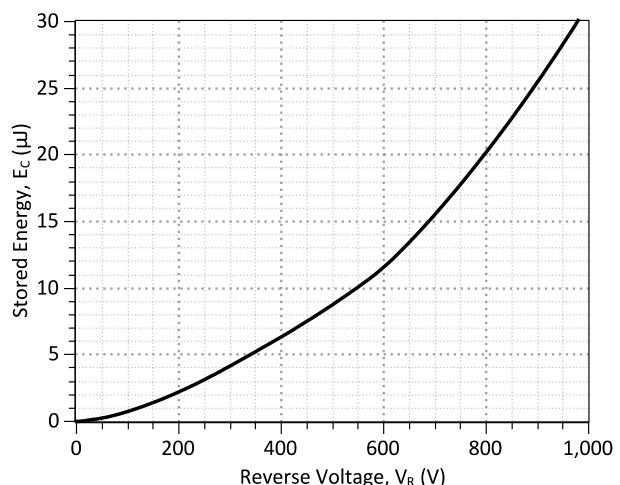


Figure 6: Typical Switching Energy vs Reverse Voltage Characteristics

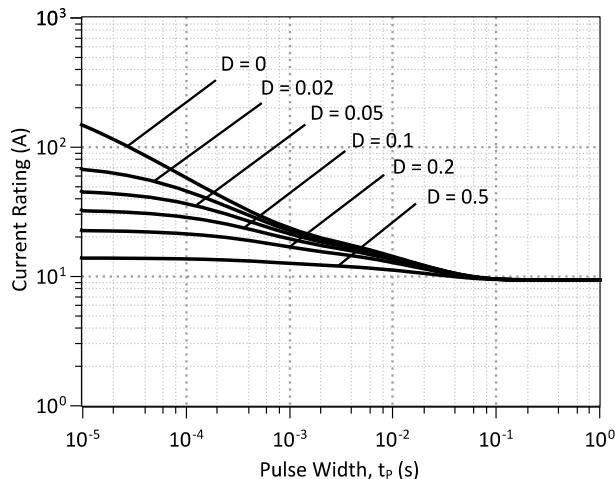


Figure 7: Current vs Pulse Duration Curves at $T_c = 225\text{ }^\circ\text{C}$

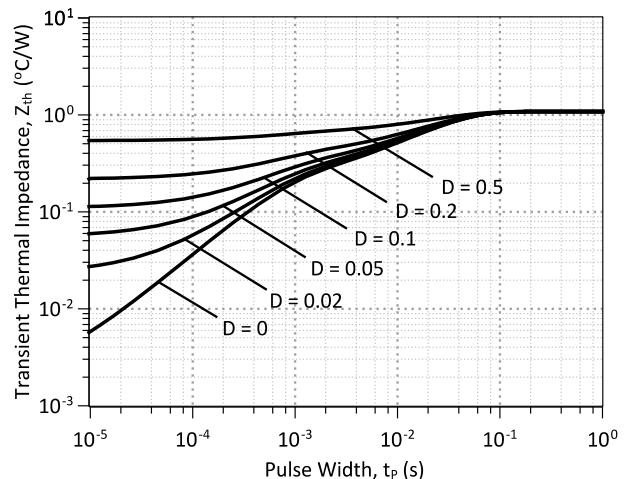
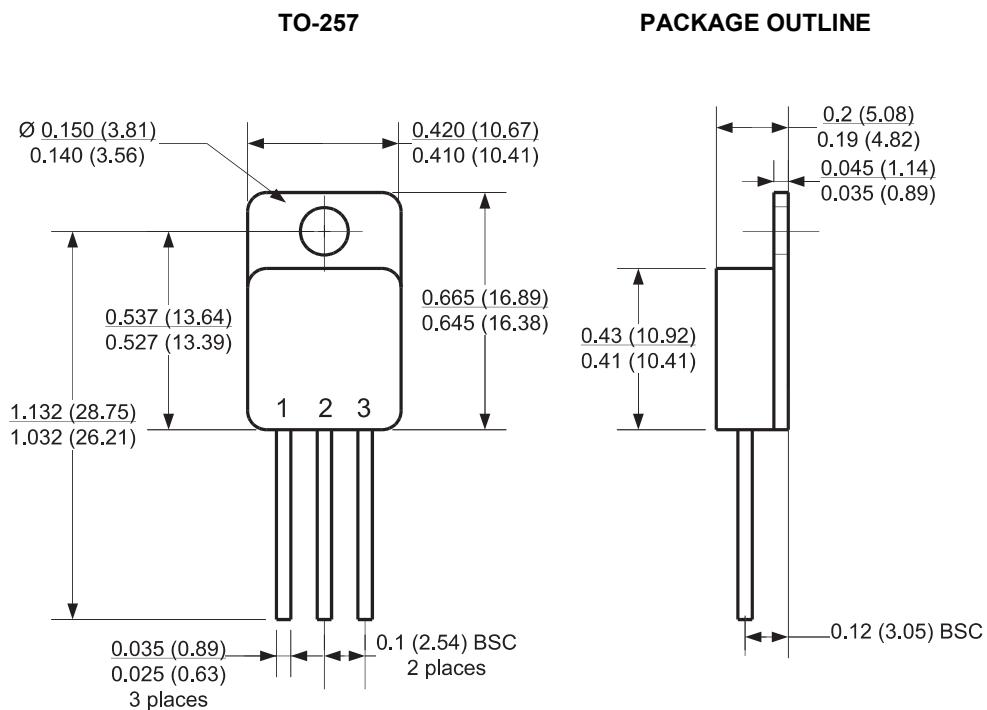


Figure 8: Transient Thermal Impedance

Package Dimensions:



NOTE

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History			
Date	Revision	Comments	Supersedes
2013/11/14	1	Updated Electrical Characteristics	
2012/04/24	0	Initial release	

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SPICE Model Parameters

Copy the following code into a SPICE software program for simulation of the 1N8028-GA device.

```

*      MODEL OF GeneSiC Semiconductor Inc.
*
*      $Revision:    1.0          $
*      $Date:      05-SEP-2013      $
*
*      GeneSiC Semiconductor Inc.
*      43670 Trade Center Place Ste. 155
*      Dulles, VA 20166
*      http://www.genesicsemi.com/index.php/hit-sic/schottky
*
*      COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.
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*
* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
* PARTICULAR PURPOSE."
* Models accurate up to 2 times rated drain current.
*
* Start of 1N8028-GA SPICE Model
*
.SUBCKT 1N8028 ANODE KATHODE
D1 ANODE KATHODE 1N8028_25C; Call the Schottky Diode Model
D2 ANODE KATHODE 1N8028_PIN; Call the PiN Diode Model
.MODEL 1N8028_25C D
+ IS      1.74E-13      RS      0.05105
+ TRS1    0.005        TRS2    1.68E-5
+ N       1.2637323    IKF     1.884319
+ EG      1.2          XTI     3
+ CJO     1.15E-09     VJ      0.44
+ M       1.5          FC      0.5
+ TT      1.00E-10     BV      1200
+ IBV     1.00E-03     VPK     1200
+ IAVE    20           TYPE    SiC_Schottky
+ MFG     GeneSiC_Semiconductor
.MODEL 1N8028_PIN D
+ IS      5.15E-15      RS      0.2
+ N       3.1605        IKF     0.00055844
+ EG      3.23          XTI     3
+ FC      0.5           TT      0
+ BV      1200           IBV    1.00E-03
+ VPK     1200           IAVE    20
+ TYPE    SiC_PiN
.ENDS
*
* End of 1N8028-GA SPICE Model

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